

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ELEFTHERIOU ET AL.	
		Examiner Shelly A Chase	Art Unit 2133	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bond et al., Low density parity check codes based on sparse matrices with no small cycles, 1997, Proceedings of the 6th IMA international Conference, pg. 47-58
	V	
	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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